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○ Home
○ What Can
   I Access?
○ Log-out

Tables of Contents

○ Journals
   & Magazines
○ Conference
   Proceedings
○ Standards

Search

○ By Author
○ Basic
○ Advanced
○ CrossRef

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○ Join IEEE
○ Establish IEEE
   Web Account
○ Access the
   IEEE Member
   Digital Library

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○ Access the
   IEEE Enterprise
   File Cabinet

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1) Enter a single keyword, phrase, or Boolean expression.
Example: acoustic imaging (means the phrase acoustic imaging
plus any stem variations)
2) Limit your search by using search operators and field codes,
if desired.
Example: optical <and> (fiber <or> fibre) <in> ti
3) Limit the results by selecting Search Options.
4) Click Search. See Search Examples

```
(nic or "interface card" )
<and> ("load-balancing"
<or> "co-processor")
```

Start Search   Clear

Note: This function returns plural and suffixed forms of the
keyword(s).

Search operators: <and> <or> <not> <in> More

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☑ IEEE Journals
☑ IEE Journals
☑ IEEE Conference proceedings
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Sort by: Relevance ⊠
In: Descending ⊠ order

List 15 ⊠ Results per page

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Publications | Help | FAQ| Terms | Back to Top